

**Search Notes****Application/Control No.**

09/900,720

**Examiner**

Christopher B. Shin

**Applicant(s)/Patent under Reexamination**

LUK ET AL.

**Art Unit**

2182

**SEARCHED**

Class	Subclass	Date	Examiner
710	5-7, 32-42	6/20/2005	CBS
710	62-74	6/20/2005	CBS
709	213-216	6/20/2005	CBS
709	250	6/20/2005	CBS
707	200+	6/20/2005	CBS
711	100-146	6/20/2005	CBS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM FOR DOUBLE PATENTING	6/20/2005	CBS
PLUS	6/20/2005	CBS
EAST (USPAT, USPGPUB, EPO, JPO, DERWENT, IBMTDB)	6/20/2005	CBS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	5, 33	6/20/2005	CBS
711	100	6/20/2005	CBS
709	250	6/20/2005	CBS
707/200		6/20/2005	CBS